

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/587,322	<b>Applicant(s)/Patent under Reexamination</b> TOKORO ET AL.
<b>Examiner</b>	Art Unit	
TAN Q. NGUYEN	3661	

**SEARCHED**

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**